

September 2013

FSAM30SM60A Motion SPM[®] 2 Series

Features

- UL Certified No. E209204
- 600 V 30 A 3 Phase IGBT Inverter Bridge Including Control ICs for Gate Driving and Protection
- Three Separate Open Emitter Pins from Low Side IGBTs for Three Leg Current Sensing
- Single-Grounded Power Supply Thanks to Built-in HVIC
- Typical Switching Frequency of 5 kHz
- Built-in Thermistor for Temperature Monitoring
- Inverter Power Rating of 2.4 kW / 100~253 VAC
- Isolation Rating of 2500 Vrms / min.
- Low Thermal Resistance by Using Ceramic Substrate
- Adjustable Current Protection Level by Changing the Value of Series Resistor Connected to the Emitters of Sense-IGBTs

Applications

• Motion Control - Home Appliance / Industrial Motor

General Description

FSAM30SM60A Is A Motion SPM® 2 Series that Fairchild Has Developed to Provide A Very Compact and Low Cost, yet High Performance Inverter Solution for AC Motor Drives in Low-Power Applications Such as Air Conditioners. It Combines Optimized Circuit Protections and Drive Matched to Low-Loss IGBTs. Effective Over-Current Protection Is Realized Through Advanced Current Sensing IGBTs. The System Reliability Is Further Enhanced by The Built-in Thermistor and Integrated Under-Voltage Lock-Out Protection. In Addition The Incorporated HVIC Facilitates The Use of Single-Supply Voltage Without Any Negative Bias. Inverter Leg Current Sensing Can Be Implemented Because of Three Separate Nagative DC Terminals.

Related Source

• AN-9043 : Motion SPM® 2 Series User's Guide

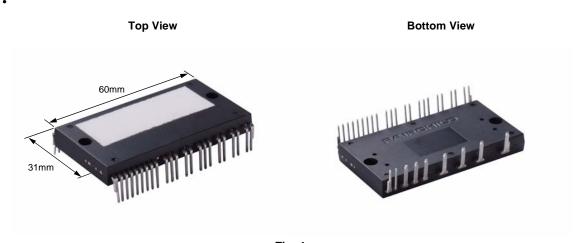


Fig. 1.

Package Marking and Ordering Information

Device Marking	Device	Package	Real Size	Packing Type	Quantity
FSAM30SM60A	FSAM30SM60A	S32AA-32	-	RAIL	8

Integrated Power Functions

• 600 V - 30 A IGBT inverter for 3 - phase DC / AC power conversion (Please refer to Fig. 3)

Integrated Drive, Protection and System Control Functions

- For inverter high-side IGBTs: Gate drive circuit, High voltage isolated high-speed level shifting
 Control circuit under-voltage (UV) protection
 Note) Available bootstrap circuit example is given in Figs. 14 and 15.
- For inverter low-side IGBTs: Gate drive circuit, Short-Circuit (SC) protection
 Control supply circuit under-voltage (UV) protection
- Temperature Monitoring: System over-temperature monitoring using built-in thermistor Note) Available temperature monitoring circuit is given in Fig. 15.
- · Fault signaling: Corresponding to a SC fault (Low-side IGBTs) or a UV fault (Low-side control supply circuit)
- Input interface: Active-low interface, can work with 3.3 / 5 V Logic

Pin Configuration

Top View

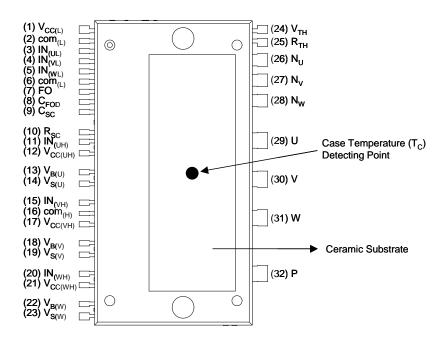
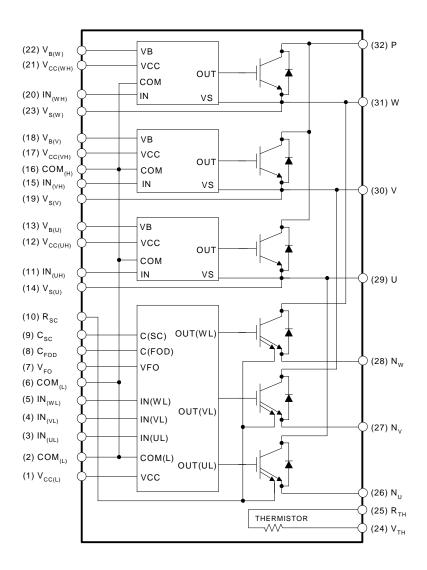


Fig. 2.

n Number	Pin Name	Pin Description
1	$V_{CC(L)}$	Low-side Common Bias Voltage for IC and IGBTs Driving
2	COM _(L)	Low-side Common Supply Ground
3	IN _(UL)	Signal Input for Low-side U Phase
4	IN _(VL)	Signal Input for Low-side V Phase
5	IN _(WL)	Signal Input for Low-side W Phase
6	COM _(L)	Low-side Common Supply Ground
7	V_{FO}	Fault Output
8	C_FOD	Capacitor for Fault Output Duration Time Selection
9	C _{SC}	Capacitor (Low-pass Filter) for Short-Circuit Current Detection Input
10	R _{SC}	Resistor for Short-Circuit Current Detection
11	IN _(UH)	Signal Input for High-side U Phase
12	V _{CC(UH)}	High-side Bias Voltage for U Phase IC
13	V _{B(U)}	High-side Bias Voltage for U Phase IGBT Driving
14	V _{S(U)}	High-side Bias Voltage Ground for U Phase IGBT Driving
15	IN _(VH)	Signal Input for High-side V Phase
16	COM _(H)	High-side Common Supply Ground
17	V _{CC(VH)}	High-side Bias Voltage for V Phase IC
18	V _{B(V)}	High-side Bias Voltage for V Phase IGBT Driving
19	V _{S(V)}	High-side Bias Voltage Ground for V Phase IGBT Driving
20	IN _(WH)	Signal Input for High-side W Phase
21	V _{CC(WH)}	High-side Bias Voltage for W Phase IC
22	$V_{B(W)}$	High-side Bias Voltage for W Phase IGBT Driving
23	V _{S(W)}	High-side Bias Voltage Ground for W Phase IGBT Driving
24	V_{TH}	Thermistor Bias Voltage
25	R_{TH}	Series Resistor for the Use of Thermistor (Temperature Detection)
26	N_{U}	Negative DC-Link Input for U Phase
27	N_V	Negative DC–Link Input for V Phase
28	N_W	Negative DC-Link Input for W Phase
29	U	Output for U Phase
30	V	Output for V Phase
31	W	Output for W Phase
32	Р	Positive DC-Link Input

Internal Equivalent Circuit and Input/Output Pins

Bottom View



- Note:

 1 Inverter low-side is composed of three sense-IGBTs including freewheeling diodes for each IGBT and one control IC which has gate driving, current sensing and protection functions.
 2) Inverter power side is composed of four inverter dc-link input pins and three inverter output pins.
 3) Inverter high-side is composed of three normal-IGBTs including freewheeling diodes and three drive ICs for each IGBT.

Fig. 3.

Absolute Maximum Ratings $(T_J = 25^{\circ}C, Unless Otherwise Specified)$

Inverter Part

Item	Symbol	Condition	Rating	Unit
Supply Voltage	V_{PN}	Applied between P- N _U , N _V , N _W	450	V
Supply Voltage (Surge)	V _{PN(Surge)}	Applied between P- N _U , N _V , N _W	500	V
Collector-Emitter Voltage	V _{CES}		600	V
Each IGBT Collector Current	± I _C	T _C = 25°C	30	А
Each IGBT Collector Current	± I _C	T _C = 100°C	16	А
Each IGBT Collector Current (Peak)	± I _{CP}	T _C = 25°, Instantaneous Value (Pulse)	60	А
Collector Dissipation	P _C	T _C = 25°C per One Chip	62	W
Operating Junction Temperature	TJ	(Note 1)	-20 ~ 125	°C

Control Part

Item	Symbol	Condition	Rating	Unit
Control Supply Voltage	V _{CC}	Applied between $V_{CC(UH)}$, $V_{CC(VH)}$, $V_{CC(WH)}$ - $COM_{(H)}$, $V_{CC(L)}$ - $COM_{(L)}$	20	V
High-side Control Bias Voltage	V _{BS}	Applied between $V_{B(U)}$ - $V_{S(U)}$, $V_{B(V)}$ - $V_{S(V)}$, $V_{B(W)}$ - $V_{S(W)}$	20	V
Input Signal Voltage	V _{IN}	Applied between $IN_{(UH)}$, $IN_{(VH)}$, $IN_{(WH)}$ - $COM_{(H)}$ $IN_{(UL)}$, $IN_{(VL)}$, $IN_{(WL)}$ - $COM_{(L)}$	-0.3 ~ V _{CC} +0.3	V
Fault Output Supply Voltage	V_{FO}	Applied between V _{FO} - COM _(L)	-0.3 ~ V _{CC} +0.3	V
Fault Output Current	I _{FO}	Sink Current at V _{FO} Pin	5	mA
Current Sensing Input Voltage	V_{SC}	Applied between C _{SC} - COM _(L)	-0.3 ~ V _{CC} +0.3	V

Total System

Item	Symbol	Condition	Rating	Unit
Self Protection Supply Voltage Limit (Short-Circuit Protection Capability)	V _{PN(PROT)}	$V_{CC} = V_{BS} = 13.5 \sim 16.5 \text{ V}$ $T_J = 125^{\circ}\text{C}$, Non-repetitive, less than $6\mu\text{s}$	400	V
Module Case Operation Temperature	T _C	Note Fig.2	-20 ~ 100	°C
Storage Temperature	T _{STG}		-20 ~ 125	°C
Isolation Voltage	V _{ISO}	60 Hz, Sinusoidal, AC 1 minute, Connection Pins to Heat-sink Plate	2500	V _{rms}

Note: 1. It would be recommended that the average junction temperature should be limited to $T_J \le 125^{\circ}C$ (@ $T_C \le 100^{\circ}C$) in order to guarantee safe operation.

Absolute Maximum Ratings

Thermal Resistance

Item	Symbol	Condition	Min.	Тур.	Max.	Unit
Junction to Case Thermal Resistance	R _{th(j-c)Q}	Each IGBT under Inverter Operating Condition	-	-	2.0	°C/W
	R _{th(j-c)F}	Each FWDi under Inverter Operating Condition	-	-	3.2	°C/W
Contact Thermal Resistance	R _{th(c-f)}	Ceramic Substrate (per 1 Module) Thermal Grease Applied (Note 3)	-	-	0.06	°C/W

- Note:
 2. For the measurement point of case temperature(T_C), please refer to Fig. 2.
 3. The thickness of thermal grease should not be more than 100um.

$\textbf{Electrical Characteristics} \quad (T_j = 25^{\circ}\text{C}, \, \text{Unless Otherwise Specified})$

Inverter Part

Item	Symbol	Condition	on	Min.	Тур.	Max.	Unit
Collector - Emitter	V _{CE(SAT)}	$V_{CC} = V_{BS} = 15 \text{ V}$ $V_{IN} = 0 \text{ V}$	$I_C = 30 \text{ A}, T_J = 25^{\circ}\text{C}$	-	-	2.3	V
Saturation Voltage		$V_{IN} = 0 V$	$I_C = 30 \text{ A}, T_J = 125^{\circ}\text{C}$	-	-	2.4	V
FWDi Forward Voltage	V_{FM}	V _{IN} = 5 V	$I_C = 30 \text{ A}, T_J = 25^{\circ}\text{C}$	-	-	2.6	V
			$I_C = 30 \text{ A}, T_J = 125^{\circ}\text{C}$	-	-	2.4	V
Switching Times	t _{ON}		V _{PN} = 300 V, V _{CC} = V _{BS} = 15 V		0.39	-	us
	t _{C(ON)}	$I_C = 30 \text{ A}, T_J = 25^{\circ}\text{C}$		-	0.2	-	us
	t _{OFF}	$V_{IN} = 5 V \leftrightarrow 0V$, Inductive Lot (High, Low-side)	oad	-	0.95	-	us
	t _{C(OFF)}	(High, Low-side)		-	0.39	-	us
	t _{rr}	(Note 4)		-	0.13	-	us
Collector - Emitter	I _{CES}	$V_{CE} = V_{CES}$, $T_J = 25$ °C		-	-	250	μΑ
Leakage Current							

4. toN and toFF include the propagation delay time of the internal drive IC. t_{C(ON)} and t_{C(OFF)} are the switching time of IGBT itself under the given gate driving condition internally. For the detailed information, please see Fig. 4.

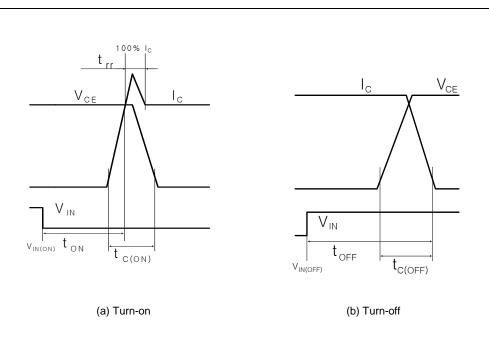


Fig. 4. Switching Time Definition

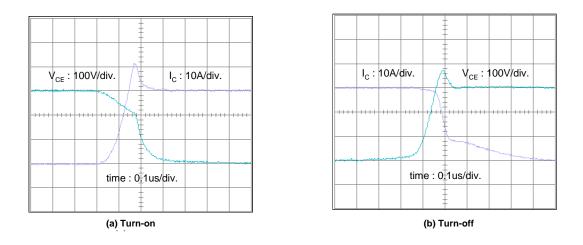


Fig. 5. Experimental Results of Switching Waveforms Test Condition: Vdc=300 V, Vcc=15 V, L = 500 uH (Inductive Load), T_j = 25°C

$\textbf{Electrical Characteristics} \quad (T_J = 25^{\circ}\text{C}, \text{ Unless Otherwise Specified})$ **Control Part**

Item	Symbol		Condition	Min.	Тур.	Max.	Unit
Control Supply Voltage	V_{CC}	Applied between		13.5	15	16.5	V
			$V_{CC(UH)}$, $V_{CC(VH)}$, $V_{CC(WH)}$, $V_{CC(L)}$ - COM				
High-side Bias Voltage	V_{BS}	Applied between $V_{B(U)}$ - $V_{S(U)}$, $V_{B(V)}$ - $V_{S(V)}$,		13.5	15	16.5	V
		V _{B(W)} - V _{S(W)}	1				
Quiescent V _{CC} Supply Cur-	IQCCL	$V_{CC} = 15 \text{ V}$	$V_{CC(L)}$ - $COM_{(L)}$	-	-	26	mA
rent		IN _(UL, VL, WL) = 5 V	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \			400	
	IQCCH	V _{CC} = 15 V	V _{CC(UH)} , V _{CC(VH)} , V _{CC(WH)} -	-	-	130	uA
Ouisseet V Supply Cur		$IN_{(UH, VH, WH)} = 5 V$ $V_{BS} = 15 V$	COM _(H)	_	_	420	uA
Quiescent V _{BS} Supply Cur- rent	I _{QBS}	$IN_{(UH, VH, WH)} = 5 V$	V _{B(U)} - V _{S(U)} , V _{B(V)} -V _{S(V)} ,	-	_	420	uA
Fault Output Voltage	V _{FOH}		t: 4.7 kΩ to 5 V Pull-up	4.5	_	-	V
	V _{FOL}		t: 4.7 kΩ to 5 V Pull-up	-	-	1.1	V
PWM Input Frequency	f _{PWM}	$T_C \le 100^{\circ}C, T_J \le 125$		-	5	-	kHz
Allowable Input Signal	t _{dead}	-20°C ≤ T _C ≤ 100°C		3	-	-	us
Blanking Time considering	dead						
Leg Arm-short							
Short-Circuit Trip Level	V _{SC(ref)}	V _{CC} = 15V (Note 5)		0.45	0.51	0.56	V
Sensing Voltage	V _{SEN}		56 Ω , $R_{SU} = R_{SV} = R_{SW} = 0 \Omega$	0.45	0.51	0.56	V
of IGBT Current		and $I_C = 45 A$ (Note F	ig. 7)				
Supply Circuit Under-	UV _{CCD}	Detection Level		11.5	12	12.5	V
Voltage Protection	UV _{CCR}	Reset Level		12	12.5	13	V
	UV_{BSD}	Detection Level		7.3	9.0	10.8	V
	UV_BSR	Reset Level		8.6	10.3	12	V
Fault Output Pulse Width	t _{FOD}	C _{FOD} = 33 nF (Note 6)		1.4	1.8	2.0	ms
ON Threshold Voltage	V _{IN(ON)}	High-Side	Applied between IN _(UH) , IN _(VH) ,	-	-	0.8	V
OFF Threshold Voltage	V _{IN(OFF)}		IN _(WH) - COM _(H)	3.0	-	-	V
ON Threshold Voltage	V _{IN(ON)}	Low-Side	Applied between IN(UL), IN(VL),	-	-	0.8	V
OFF Threshold Voltage	V _{IN(OFF)}		IN _(WL) - COM _(L)	3.0	-	-	V
Resistance of Thermistor	R _{TH}	@ T _{TH} = 25°C (Note	Fig. 6)	-	50	-	kΩ
		@ T _{TH} = 100°C (Note	Fig. 6)	-	3.4	-	kΩ

Recommended Operating Conditions

Item	Cumbal	ool Condition		Values			
item	Symbol Condition		Min.	Тур.	Max.	Unit	
Supply Voltage	V_{PN}	Applied between P - N _U , N _V , N _W	-	300	400	V	
Control Supply Voltage	V _{CC}	Applied between $V_{CC(UH)}$, $V_{CC(VH)}$, $V_{CC(WH)}$ - $COM_{(H)}$, $V_{CC(L)}$ - $COM_{(L)}$	13.5	15	16.5	V	
High-side Bias Voltage	V_{BS}	Applied between $V_{B(U)}$ - $V_{S(U)}$, $V_{B(V)}$ - $V_{S(V)}$, $V_{B(W)}$ - $V_{S(W)}$	13.5	15	16.5	V	
Blanking Time for Preventing Arm-short	t _{dead}	For Each Input Signal	3	1	-	us	
PWM Input Signal	f _{PWM}	$T_C \le 100$ °C, $T_J \le 125$ °C	-	5	-	kHz	
Input ON Threshold Voltage	V _{IN(ON)}	Applied between IN _(UH) , IN _(VH) , IN _(WH) - COM _(H)		0 ~ 0.65	5	V	
Input OFF Threshold Voltage	V _{IN(OFF)}	Applied between $IN_{(UL)}$, $IN_{(VL)}$, $IN_{(WL)}$ - $COM_{(L)}$		4 ~ 5.5		V	

<sup>Note:
5. Short-circuit current protection is functioning only at the low-sides. It would be recommended that the value of the external sensing resistor (R_{SC}) should be selected around 56 Ω in order to make the SC trip-level of about 45 A at the shunt resistors (R_{SU},R_{SV},R_{SW}) of 0 Ω . For the detailed information about the relationship between the external sensing resistor (R_{SC}) and the shunt resistors (R_{SU},R_{SW},R_{SW}), please see Fig. 7.
6. The fault-out pulse width t_{FOD} depends on the capacitance value of C_{FOD} according to the following approximate equation: C_{FOD} = 18.3 x 10⁻⁶ x t_{FOD}[F]
7. T_{TH} is the temperature of thermistor</sup>

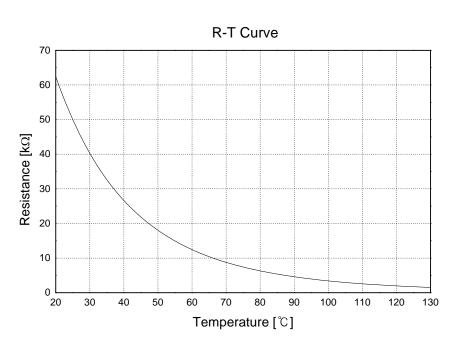


Fig. 6. R-T Curve of The Built-in Thermistor

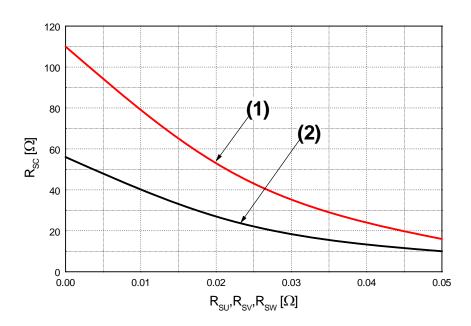


Fig. 7. R_{SC} Variation by change of Shunt Resistors (R_{SU}, R_{SV}, R_{SW}) for Short-Circuit Protection (1) @ around 100% Rated Current Trip (I_C '=. 30 A) (2) @ around 150% Rated Current Trip (I_C '=. 45 A)

Mechanical Characteristics and Ratings

ltom		Condition		Limits		l lmi4
Item		Condition	Min.	Тур.	Max.	Unit
Mounting Torque	Mounting Screw: M4	Recommended 10 Kg•cm	8	10	12	Kg•cm
	(Note 8 and 9)	Recommended 0.98 N•m	0.78	0.98	1.17	N•m
Ceramic Flatness		Note Fig.8	0	-	+120	um
Weight			-	35	-	g

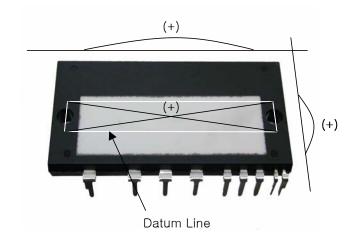


Fig. 8. Flatness Measurement Position of The Ceramic Substrate

- Note:

 8. Do not make over torque or mounting screws. Much mounting torque may cause ceramic cracks and bolts and Al heat-fin destruction.

 9. Avoid one side tightening stress. Fig.9 shows the recommended torque order for mounting screws. Uneven mounting can cause the Motion SPM® 2 Package ceramic substrate to be damaged.

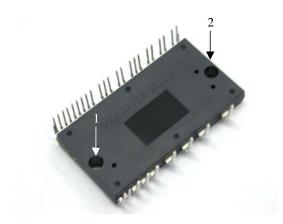
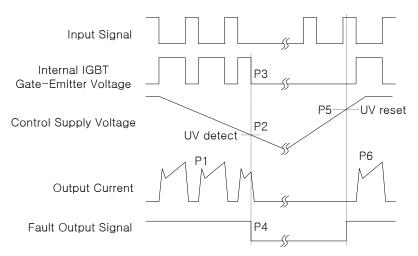


Fig. 9. Mounting Screws Torque Order

Time Charts of Protective Function

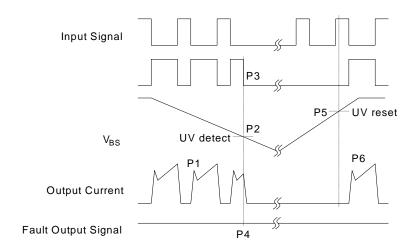


P1: Normal operation - IGBT ON and conducting current

P2 : Under-Voltage detection P3 : IGBT gate interrupt P4 : Fault signal generation P5 : Under-Voltage reset

P6: Normal operation - IGBT ON and conducting current

Fig. 10. Under-Voltage Protection (Low-side)

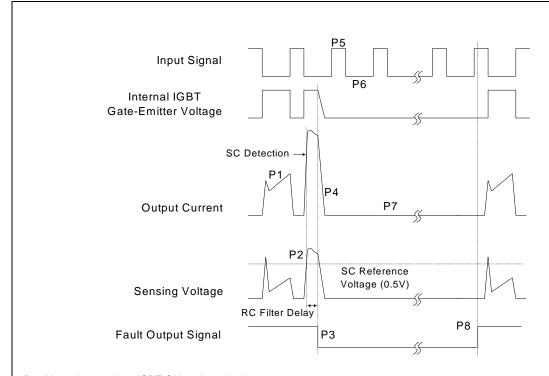


P1: Normal operation - IGBT ON and conducting current

P2: Under-Voltage detection P3: IGBT gate interrupt P4: No fault signal P5: Under-Voltage reset

P6: Normal operation - IGBT ON and conducting current

Fig. 11. Under-Voltage Protection (High-side)



P1: Normal operation - IGBT ON and conducting current

P2 : Short-Circuit current detection

P3: IGBT gate interrupt / Fault signal generation

P4: IGBT is slowly turned off

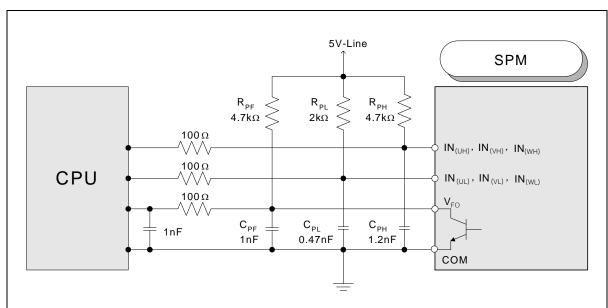
P5 : IGBT OFF signal

P6: IGBT ON signal - but IGBT cannot be turned on during the fault Output activation

P7: IGBT OFF state

P8 : Fault Output reset and normal operation start

Fig. 12. Short-Circuit Current Protection (Low-side Operation only)



Note:

- Note:

 1) It would be recommended that by-pass capacitors for the gating input signals, IN_(UL), IN_(VL), IN_(UL), IN_(UH), IN_(UH), IN_(UH) and IN_(WH) should be placed on the Motion SPM® 2 Product pins and on the both sides of CPU and Motion SPM 2 Product for the fault output signal, V_{FO}, as close as possible.

 2) The logic input is compatible with standard CMOS or LSTTL outputs.

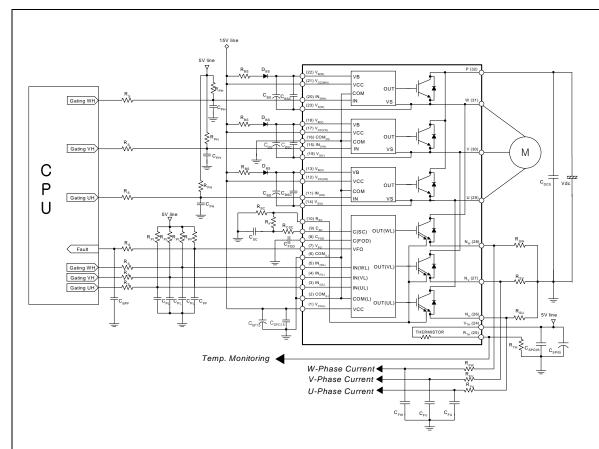
 3) R_{PL}C_{PL} / R_{PH}C_{PH} / R_{PF}C_{PF} coupling at each Motion SPM 2 Product input is recommended in order to prevent input/output signals' oscillation and it should be as close as possible to each of Motion SPM 2 Product pins.

Fig. 13. Recommended CPU I/O Interface Circuit

These Values depend on PWM Control Algorithm 15V-Line One-Leg Diagram of Motion SPM® 2 Product Ρ D_{BS} **20**Ω 0.1uF Vcc VΒ INI HO 22uF COM VS Inverter -Output Vcc 470uF > 0.1uF IN OUT сом Ν

Note:
It would be recommended that the bootstrap diode, D_{BS}, has soft and fast recovery characteristics.

Fig. 14. Recommended Bootstrap Operation Circuit and Parameters



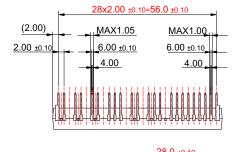
- NR_{PL}C_{PL} / R_{PH}C_{PH} / R_{PF}C_{PF} coupling at each Motion SPM[®] 2 Product input is recommended in order to prevent input signals' oscillation and it should be as close as possible to each Motion SPM 2 Product input pin.
- 2) By virtue of integrating an application specific type HVIC inside the Motion SPM 2 Product, direct coupling to CPU terminals without any opto-coupler or transformer isolation is possible.
- No output is open collector type. This signal line should be pulled up to the positive side of the 5 V power supply with approximately 4.7 kΩ resistance. Please refer to Fig. 15.
- C_{SP15} of around 7 times larger than bootstrap capacitor C_{BS} is recommended.
- V_{FO} output pulse width should be determined by connecting an external capacitor(C_{FOD}) between C_{FOD}(pin8) and COM_(L)(pin2). (Example : if C_{FOD} = 33 nF, then
- to the coupling circuits at each input may be needed depending on the PWM control scheme used and on the wiring impedance of the system's printed circuit board).
- Approximately a 0.22–2 nF by-pass capacitor should be used across each power supply connection terminals. To prevent errors of the protection function, the wiring around R_{SC} , R_F and C_{SC} should be as short as possible. In the short-circuit protection circuit, please select the R_FC_{SC} time constant in the range 3–4 μ s. Each capacitor should be mounted as close to the pins of the Motion SPM 2 Product as possible.

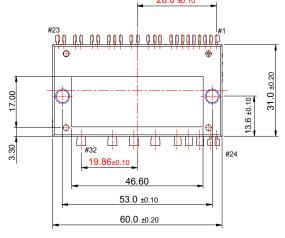
- 10)To prevent surge destruction, the wiring between the smoothing capacitor and the P&N pins should be as short as possible. The use of a high frequency non-inductive capacitor of around 0.1~0.22 uF between the P&N pins is recommended.
- 11)Relays are used at almost every systems of electrical equipments of home appliances. In these cases, there should be sufficient distance between the CPU and the relays. It is recommended that the distance be 5cm at least.

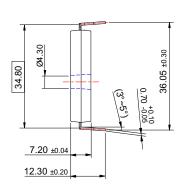
Fig. 15. Typical Application Circuit

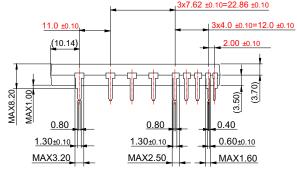
Detailed Package Outline Drawings

S32AA-032









Dimensions in Millimeters





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 - system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition			
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.			
		Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.			
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.			
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.			

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